



### 1. SCOPE

This specification is applied to a SAW resonator designed for the stabilization of transmitters such as garage door openers and security transmitters.

## 2. EL ECTRICAL SPECIFICATION

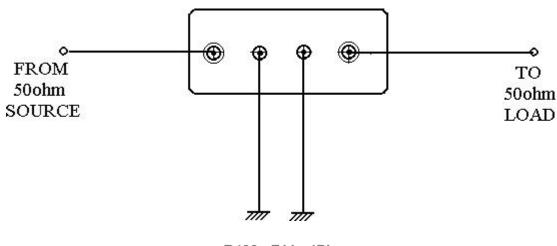
#### 2.1 Maximum Rating

DC Voltage VDC	1 0 V
AC Voltage Vpp	10V 50Hz/60Hz
Operation temperature	-40°C to +85°C
Storage temperature	-45℃ to +85℃
Max Input Power	1 0 dBm

#### 2.2Electronic Characteristics

Item			Unites	Minimum	Typical	Maximum
Center Frequency			MHz	433.845	433.920	433.995
Insertion Loss			dB		1.6	2.2
Quality Factor		Unload Q		8300	12000	
		50Ω Loaded Q		850	1500	
Temperature	Turnover Temperature		°C	10	25	40
Stability	Freq.temp.Coefficient		ppm/°C		0.032	
Frequency Aging			ppm/yr		<±10	
DC. Insulation Resistance			MΩ	1.0		
RF	Motional Resistance R1		Ω		18	26
Equivalent	Motional Inductance L1		μH		79.82	
RLC Model	Motional Capacitance C1		fF		1.685	
Transducer Static Capacitance C0			pF		2.3	

# **3. TEST CIRCUIT**

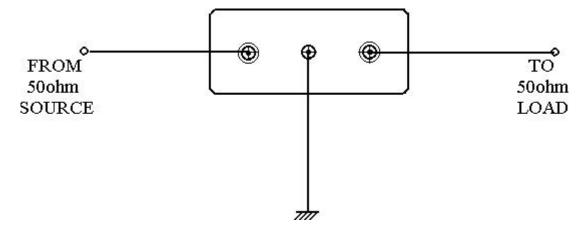


R433 F11 4Pin



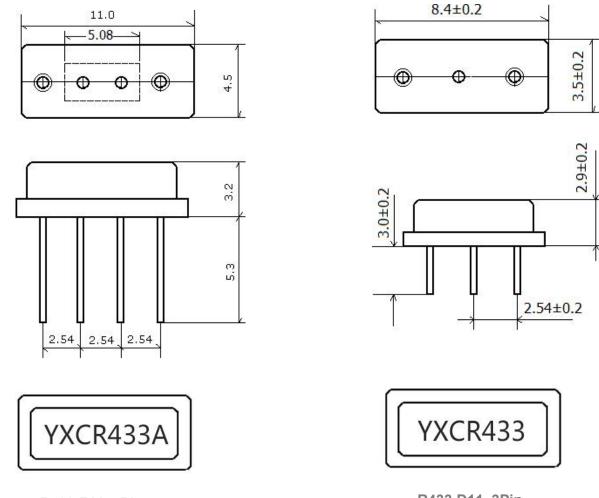






R433 D11 3Pin

## **4. DIMENSION**



R433 F11 4Pin

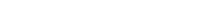
R433 D11 3Pin

## **5. ENVIRONMENTAL CHARACTERISTICS**

5-1 High temperature exposure

Subject the device to  $+85^{\circ}$ C for 16 hours. Then release the resonator into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

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5-2 Low temperature exposure

Subject the device to  $-40^{\circ}$ C for 16 hours. Then release the device into the room conditions for 24 hours prior to the measurement. It shall fulfill the specifications in 2.2.

R433

#### 5-3 Temperature cycling

Subject the device to a low temperature of  $-40^{\circ}$ C for 30 minutes. Following by a high temperature of  $+85^{\circ}$ C for 30 Minutes. Then release the device into the room conditions for 24 hours prior to the measurement. It shall meet the specifications in 2.2.

#### 5-4 Resistance to solder heat

Dip the device terminals no closer than 1.5mm into the solder bath at  $260^{\circ}$ C  $\pm 10^{\circ}$ C for  $10\pm 1$  sec. Then release the device into the room conditions for 4 hours. The device shall meet the specifications in 2.2.

#### 5-5 Solderability

Subject the device terminals into the solder bath at  $245^{\circ}$ C  $\pm 5^{\circ}$ C for 5s, More than 95% area of the terminals must be covered with new solder. It shall meet the specifications in 2.2.

#### 5-6 Mechanical shock

Drop the device randomly onto the concrete floor from the height of 1m 3 times. the device shall fulfill the specifications in 2.2.

#### 5-7 Vibration

Subject the device to the vibration for 1 hour each in x, y and z axes with the amplitude of 1.5 mm at 10 to 55 Hz. The device shall fulfill the specifications in 2.2.

### 6. REMARK

#### 6.1 Static voltage

Static voltage between signal load & ground may cause deterioration & destruction of the component. Please avoid static voltage.

#### 6.2 Ultrasonic cleaning

Ultrasonic vibration may cause deterioration & destruction of the component. Please avoid ultrasonic cleaning

#### 6.3 Soldering

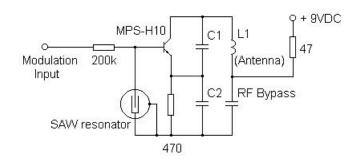
Only leads of component may be soldered. Please avoid soldering another part of component.



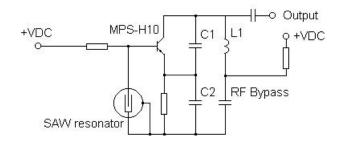


# **7.TYPCIAL APPLICATION CIRCUITS**

Typical low-power Transmitter Application



### Typical Local Oscillator Application



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